

图书基本信息

书名：<<软件测试形式方法/会议文集Formal Approaches to Software Testing>>

13位ISBN编号：9783540251095

10位ISBN编号：354025109X

出版时间：2005-04-19

出版时间：Springer

作者：Grabowski, Jens; Nielsen, Brian;

页数：224

版权说明：本站所提供下载的PDF图书仅提供预览和简介，请支持正版图书。

更多资源请访问：<http://www.tushu007.com>

内容概要

The LNCS series reports state-of-the-art results in computer science research, development, and education, at a high level and in both printed and electronic form. Enjoying tight cooperation with the R&D community, with numerous individuals, as well as with prestigious organizations and societies, LNCS has grown into the most comprehensive computer science research forum available. The scope of LNCS, including its subseries LNAI and LNBI, spans the whole range of computer science and information technology including interdisciplinary topics in a variety of application fields. The type of material published traditionally includes

- proceedings- (published in time for the respective conference)
- post-proceedings (consisting of thoroughly revised final full papers)
- research monographs (which may be based on outstanding PhD work, research projects, technical reports, etc.)

书籍目录

Symbolic Test Generation Test Generation Based on Symbolic Specifications Symbolic Test Case Generation for Primitive Recursive Functions Preserving Contexts for Soft Conformance Relation Testing Non-functional Properties Testing of Symbolic-Probabilistic Systems A Test Generation Framework for quiescent Real-Time Systems Online Testing of Real-Time Systems Using UPPAAL Testing Deadlock-Freeness in Real-Time Systems; A Formal Approach Test Development with Model Checking Techniques Using Model Checking for Reducing the Cost of Test Generation Specifying and Generating Test Cases Using Observer Automata Semi-formal Development of a Fault-Tolerant Leader Election Protocol in Erlang An Automata-Theoretic Approach for Model-Checking Systems with Unspecified Components Test Optimization Test Patterns with TTCN-3 High-Level Restructuring of TTCN-3 Test Data Ordering Mutants to Minimise Test Effort in Mutation Testing Testing COM Components Using Software Fault Injection and Mutation Analysis, and Its Empirical Study Author Index

版权说明

本站所提供下载的PDF图书仅提供预览和简介，请支持正版图书。

更多资源请访问:<http://www.tushu007.com>